

MCP1406/07

6A High-Speed Power MOSFET Drivers

Features

- High Peak Output Current: 6.0A (typ.)
- Low Shoot-Through/Cross-Conduction Current in Output Stage
- · Wide Input Supply Voltage Operating Range:
 - 4.5V to 18V
- · High Capacitive Load Drive Capability:
 - 2500 pF in 20 ns
 - 6800 pF in 40 ns
- · Short Delay Times: 40 ns (typ.)
- · Matched Rise/Fall Times
- · Low Supply Current:
 - With Logic '1' Input 130 μA (typ.)
 - With Logic '0' Input 35 μA (typ.)
- Latch-Up Protected: Will Withstand 1.5A Reverse Current
- Logic Input Will Withstand Negative Swing Up To 5V
- · Pin compatible with the TC4420/TC4429 devices
- Space-saving 8-Pin SOIC, PDIP and 8-Pin 6x5 DFN Packages

Applications

- Switch Mode Power Supplies
- · Pulse Transformer Drive
- · Line Drivers
- Motor and Solenoid Drive

General Description

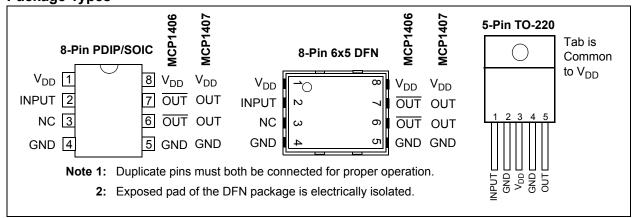
The MCP1406/07 devices are a family of buffers/MOSFET drivers that feature a single-output with 6A peak drive current capability, low shoot-through current, matched rise/fall times and propagation delay times. These devices are pin-compatible and are improved versions of the TC4420/TC4429 MOSFET drivers.

The MCP1406/07 MOSFET drivers can easily charge and discharge 2500 pF gate capacitance in under 20 ns, provide low enough impedances in both the on and off states to ensure the MOSFETs intended state will not be affected, even by large transients. The input to the MCP1406/07 may be driven directly from either TTL or CMOS (3V to 18V).

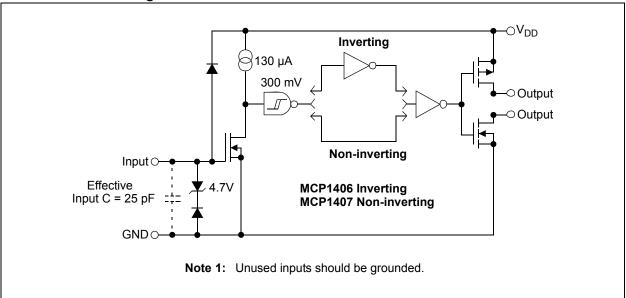
These devices are highly latch-up resistant under any conditions within their power and voltage ratings. They are not subject to damage when up to 5V of noise spiking (of either polarity) occurs on the ground pin. All terminals are fully protect against Electrostatic Discharge (ESD) up to 4 kV.

The MCP1406/07 single-output 6A MOSFET driver family is offered in both surface-mount and pinthrough-hole packages with a -40°C to +125°C temperature rating, making it useful in any wide temperature range application.

Package Types



Functional Block Diagram⁽¹⁾



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

Supply Voltage +20V Input Voltage $(V_{DD} + 0.3V)$ to (GND - 5V) Input Current $(V_{IN} > V_{DD})$ 50 mA

† **Notice:** Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

DC CHARACTERISTICS

Electrical Specifications: Unless otherwise indicated, $T_A = +25^{\circ}C$, with $4.5V \le V_{DD} \le 18V$.								
Parameters	Sym	Min	Тур	Max	Units	Conditions		
Input								
Logic '1', High Input Voltage	V _{IH}	2.4	1.8	_	V			
Logic '0', Low Input Voltage	V _{IL}	_	1.3	0.8	V			
Input Current	I _{IN}	-10	_	10	μΑ	$0V \le V_{IN} \le V_{DD}$		
Input Voltage	V_{IN}	-5	_	V _{DD} +0.3	V			
Output								
High Output Voltage	V _{OH}	$V_{DD} - 0.025$	_	_	V	DC Test		
Low Output Voltage	V_{OL}	_	_	0.025	V	DC Test		
Output Resistance, High	R _{OH}	_	2.1	2.8	Ω	I _{OUT} = 10 mA, V _{DD} = 18V		
Output Resistance, Low	R _{OL}	_	1.5	2.5	Ω	I _{OUT} = 10 mA, V _{DD} = 18V		
Peak Output Current	I _{PK}	_	6	_	Α	V _{DD} = 18V (Note 2)		
Continuous Output Current	I _{DC}	1.3			Α	Note 2, Note 3		
Latch-Up Protection Withstand Reverse Current	I _{REV}	_	1.5	_	Α	Duty cycle \leq 2%, t \leq 300 µsec.		
Switching Time (Note 1)								
Rise Time	t _R	_	20	30	ns	Figure 4-1, Figure 4-2 C _L = 2500 pF		
Fall Time	t _F	_	20	30	ns	Figure 4-1, Figure 4-2 C _L = 2500 pF		
Delay Time	t _{D1}	_	40	55	ns	Figure 4-1, Figure 4-2		
Delay Time	t _{D2}	_	40	55	ns	Figure 4-1, Figure 4-2		
Power Supply								
Supply Voltage	V_{DD}	4.5	_	18.0	V			
Power Supply Current	I _S	_	130	250	μA	V _{IN} = 3V		
	I _S	_	35	100	μA	V _{IN} = 0V		

- Note 1: Switching times ensured by design.
 - 2: Tested during characterization, not production tested.
 - 3: Valid for AT and MF packages only. $T_A = +25$ °C

DC CHARACTERISTICS (OVER OPERATING TEMPERATURE RANGE)

Electrical Specifications: Unless otherwise indicated, operating temperature range with $4.5V \le V_{DD} \le 18V$.									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
Input									
Logic '1', High Input Voltage	V_{IH}	2.4	_	_	V				
Logic '0', Low Input Voltage	V _{IL}	_	_	0.8	V				
Input Current	I _{IN}	-10	_	+10	μA	$0V \le V_{IN} \le V_{DD}$			
Input Voltage	V_{IN}	-5	_	V _{DD} +0.3	V				
Output									
High Output Voltage	V _{OH}	V _{DD} – 0.025	_	_	٧	DC TEST			
Low Output Voltage	V _{OL}	_	_	0.025	V	DC TEST			
Output Resistance, High	R _{OH}	_	3.0	5.0	Ω	I _{OUT} = 10 mA, V _{DD} = 18V			
Output Resistance, Low	R _{OL}	_	2.3	5.0	Ω	I _{OUT} = 10 mA, V _{DD} = 18V			
Switching Time (Note 1)									
Rise Time	t _R	_	25	40	ns	Figure 4-1, Figure 4-2 C _L = 2500 pF			
Fall Time	t _F	_	25	40	ns	Figure 4-1, Figure 4-2 C _L = 2500 pF			
Delay Time	t _{D1}	_	50	65	ns	Figure 4-1, Figure 4-2			
Delay Time	t _{D2}	_	50	65	ns	Figure 4-1, Figure 4-2			
Power Supply									
Supply Voltage	V_{DD}	4.5	_	18.0	V				
Power Supply Current	I _S	_	200	500	μΑ	V _{IN} = 3V			
		_	50	150		V _{IN} = 0V			

Note 1: Switching times ensured by design.

TEMPERATURE CHARACTERISTICS

Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5V \le V_{DD} \le 18V$.									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
Temperature Ranges									
Specified Temperature Range	T _A	-4 0	_	+125	°C				
Maximum Junction Temperature	TJ	_	_	+150	°C				
Storage Temperature Range	T _A	-65	_	+150	°C				
Package Thermal Resistances									
Thermal Resistance, 8L-6x5 DFN	$\theta_{\sf JA}$	_	33.2	_	°C/W	Typical four-layer board with vias to ground plane			
Thermal Resistance, 8L-PDIP	$\theta_{\sf JA}$	_	125	_	°C/W				
Thermal Resistance, 8L-SOIC	$\theta_{\sf JA}$	_	155	_	°C/W				
Thermal Resistance, 5L-TO-220	$\theta_{\sf JA}$	_	71	_	°C/W				

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with 4.5V <= V_{DD} <= 18V.

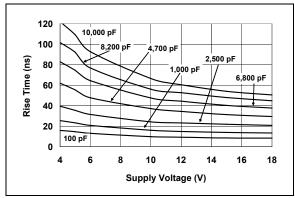


FIGURE 2-1: Rise Time vs. Supply Voltage.

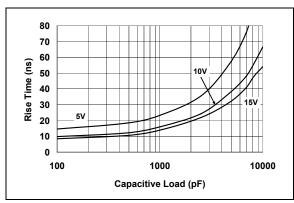


FIGURE 2-2: Rise Time vs. Capacitive Load.

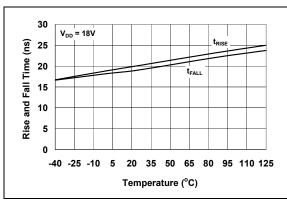


FIGURE 2-3: Rise and Fall Times vs. Temperature.

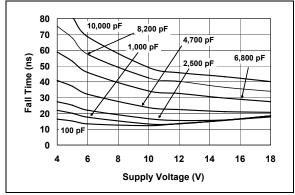


FIGURE 2-4: Fall Time vs. Supply Voltage.

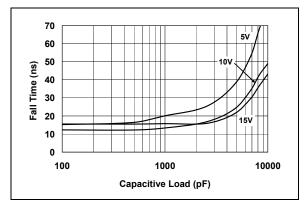


FIGURE 2-5: Fall Time vs. Capacitive Load.

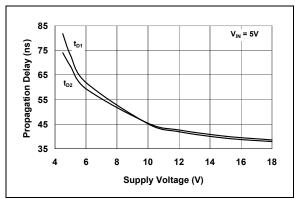


FIGURE 2-6: Propagation Delay vs. Supply Voltage.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with 4.5V <= V_{DD} <= 18V.

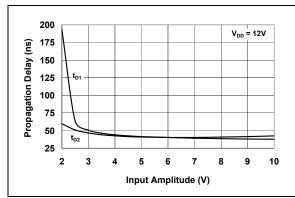


FIGURE 2-7: Propagation Delay Time vs. Input Amplitude.

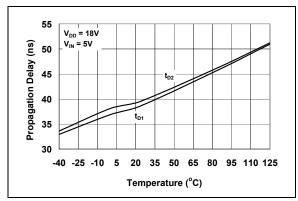


FIGURE 2-8: Propagation Delay Time vs. Temperature.

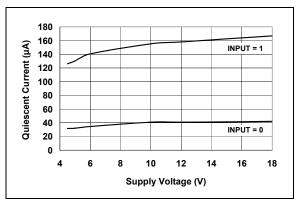


FIGURE 2-9: Quiescent Current vs. Supply Voltage.

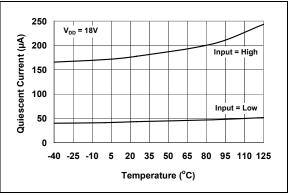


FIGURE 2-10: Quiescent Current vs. Temperature.

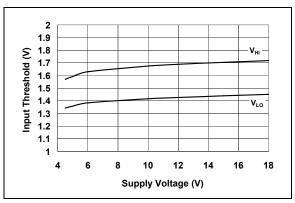


FIGURE 2-11: Input Threshold vs. Supply Voltage.

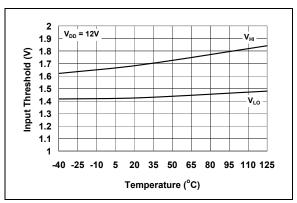


FIGURE 2-12: Input Threshold vs. Temperature.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with 4.5V <= V_{DD} <= 18V.

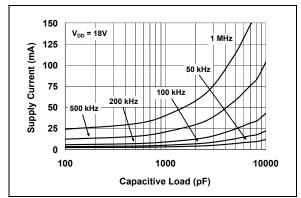


FIGURE 2-13: Supply Current vs. Capacitive Load.

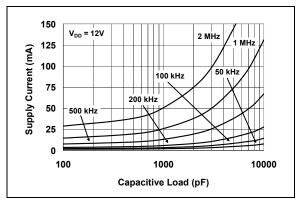


FIGURE 2-14: Supply Current vs. Capacitive Load.

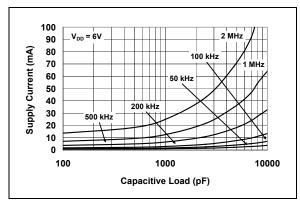


FIGURE 2-15: Supply Current vs. Capacitive Load.

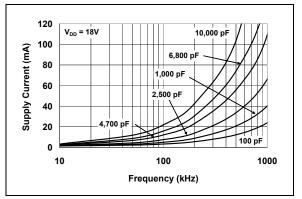


FIGURE 2-16: Supply Current vs. Frequency.

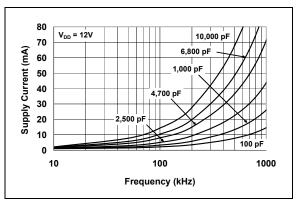


FIGURE 2-17: Supply Current vs. Frequency.

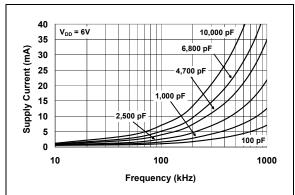


FIGURE 2-18: Supply Current vs. Frequency.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, T_A = +25°C with 4.5V <= V_{DD} <= 18V.

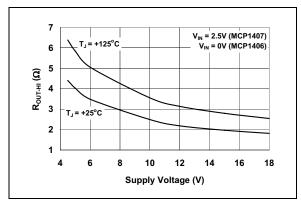


FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.

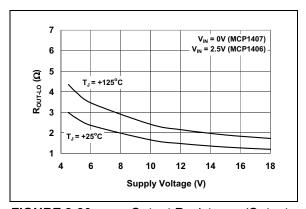


FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.

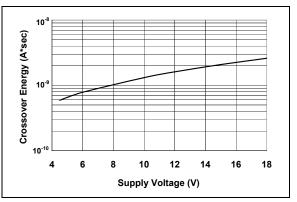


FIGURE 2-21: Crossover Energy vs. Supply Voltage.

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE (1)

8-Pin PDIP, SOIC	8-Pin DFN	5-Pin TO-220	Symbol	Description
1	1	_	V_{DD}	Supply Input
2	2	1	INPUT	Control Input
3	3	_	NC	No Connection
4	4	2	GND	Ground
5	5	4	GND	Ground
6	6	5	OUTPUT	CMOS Push-Pull Output
7	7	_	OUTPUT	CMOS Push-Pull Output
8	8	3	V_{DD}	Supply Input
_	PAD	_	NC	Exposed Metal Pad
_		TAB	V_{DD}	Metal Tab at V _{DD} Potential

Note 1: Duplicate pins must be connected for proper operation.

3.1 Supply Input (V_{DD})

 V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with local capacitors. The bypass capacitors provide a localized low-impedance path for the peak currents that are to be provided to the load.

3.2 Control Input (INPUT)

The MOSFET driver input is a high-impedance, TTL/CMOS-compatible input. The input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals, and to provide noise immunity.

3.3 Ground (GND)

Ground is the device return pin. The ground pin should have a low impedance connection to the bias supply source return. High peak currents will flow out the ground pin when the capacitive load is being discharged.

3.4 CMOS Push-Pull Output (OUTPUT)

The output is a CMOS push-pull output that is capable of sourcing peak currents of 6A (V_{DD} = 18V). The low output impedance ensures the gate of the external MOSFET will stay in the intended state even during large transients. These output also has a reverse current latch-up rating of 1.5A.

3.5 Exposed Metal Pad

The exposed metal pad of the DFN package is not internally connected to any potential. Therefore, this pad can be connected to a ground plane or other copper plane on a printed circuit board to aid in heat removal from the package.

3.6 TO-220 Metal Tab

The metal tab on the TO-220 package is at V_{DD} potentail. This metal tab is not intended to be the V_{DD} connection to MCP1406/07. V_{DD} should be supplied using the Supply Input pin of the TO-220.

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high current devices which are intended to provide high peak currents to charge the gate capacitance of external MOSFETs or IGBTs. In high frequency switching power supplies, the PWM controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver like the MCP1406/07 family can be used to provide additional drive current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fully off state to a fully on state are characterized by the drivers rise time (t_R), fall time (t_F), and propagation delays (t_{D1} and t_{D2}). The MCP1406/07 family of devices is able to make this transition very quickly. Figure 4-1 and Figure 4-2 show the test circuits and timing waveforms used to verify the MCP1406/07 timing.

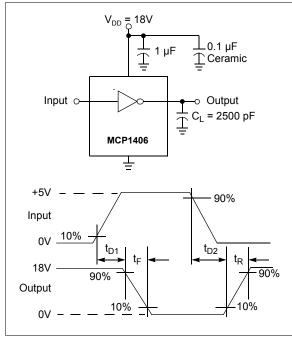


FIGURE 4-1: Inverting Driver Timing Waveform.

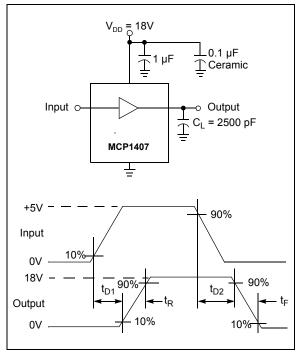


FIGURE 4-2: Non-Inverting Driver Timing Waveform.

4.3 Decoupling Capacitors

Careful layout and decoupling capacitors are highly recommended when using MOSFET drivers. Large currents are required to charge and discharge capacitive loads quickly. For example, 2.25A are needed to charge a 2500 pF load with 18V in 20 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, a ceramic and low ESR film capacitor are recommended to be placed in parallel between the driver V_{DD} and GND. A 1.0 μF low ESR film capacitor and a 0.1 μF ceramic capacitor placed between pins 1, 8 and 4, 5 should be used. These capacitors should be placed close to the driver to minimized circuit board parasitics and provide a local source for the required current.

4.4 PCB Layout Considerations

Proper PCB layout is important in a high current, fast switching circuit to provide proper device operation and robustness of design. PCB trace loop area and inductance should be minimized by the use of a ground plane or ground trace located under the MOSFET gate drive signals, separate analog and power grounds, and local driver decoupling.

The MCP1406/07 devices have two pins each for V_{DD} , OUTPUT, and GND. Both pins must be used for proper operation. This also lowers path inductance which will, along with proper decoupling, help minimize ringing in the circuit.

Placing a ground plane beneath the MCP1406/07 will help as a radiated noise shield as well as providing some heat sinking for power dissipated within the device.

4.5 Power Dissipation

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements.

$$P_T = P_L + P_O + P_{CC}$$

Where:

 P_T = Total power dissipation

P_I = Load power dissipation

PQ = Quiescent power dissipation

P_{CC} = Operating power dissipation

4.5.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of frequency, total capacitive load, and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is:

$$P_L = f \times C_T \times V_{DD}^{2}$$

Where:

f = Switching frequency

C_T = Total load capacitance

V_{DD} = MOSFET driver supply voltage

4.5.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends upon the state of the input pin. The MCP1406/07 devices have a quiescent current draw when the input is high of 0.13 mA (typ) and 0.035 mA (typ) when the input is low. The quiescent power dissipation is:

$$P_Q = (I_{QH} \times D + I_{QL} \times (1 - D)) \times V_{DD}$$

Where:

I_{QH} = Quiescent current in the high state

D = Duty cycle

I_{OL} = Quiescent current in the low state

V_{DD} = MOSFET driver supply voltage

4.5.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because for a very short period of time both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation describes as:

$$P_{CC} = CC \times f \times V_{DD}$$

Where:

CC = Cross-conduction constant (A*sec)

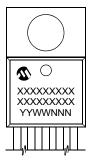
f = Switching frequency

V_{DD} = MOSFET driver supply voltage

5.0 PACKAGING INFORMATION

5.1 Package Marking Information (Not to Scale)

5-Lead TO-220



8-Lead DFN



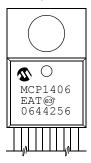
8-Lead PDIP (300 mil)



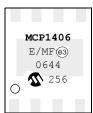
8-Lead SOIC (150 mil)



Example



Example:



Example:



Example:



Legend: XX...X Customer-specific information

Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')
NNN Alphanumeric traceability code

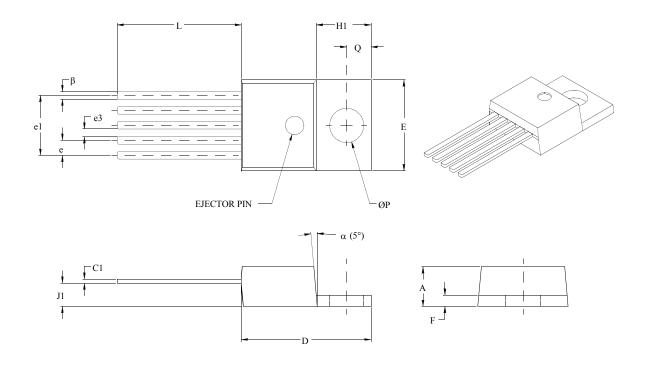
(e3) Pb-free JEDEC designator for Matte Tin (Sn)

This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package.

te: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

5-Lead Plastic Transistor Outline (AT) (TO-220)

lote: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			MILLIMETERS		
Dimension	n Limits	MIN	MAX	MIN	MAX	
Lead Pitch	е	.060	.072	1.52	1.83	
Overall Lead Centers	e1	.263	.273	6.68	6.93	
Space Between Leads	e3	.030	.040	0.76	1.02	
Overall Height	А	.160	.190	4.06	4.83	
Overall Width	E	.385	.415	9.78	10.54	
Overall Length	D	.560	.590	14.22	14.99	
Flag Length	H1	.234	.258	5.94	6.55	
Flag Thickness	F	.045	.055	1.14	1.40	
Through Hole Center	Q	.103	.113	2.62	2.87	
Through Hole Diameter	Р	.146	.156	3.71	3.96	
Lead Length	L	.540	.560	13.72	14.22	
Base to Bottom of Lead	J1	.090	.115	2.29	2.92	
Lead Thickness	C1	.014	.022	0.36	0.56	
Lead Width	β	.025	.040	0.64	1.02	
Mold Draft Angle	α	3°	7°	3°	7°	

^{*} Controlling Parameter

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254 mm) per side.

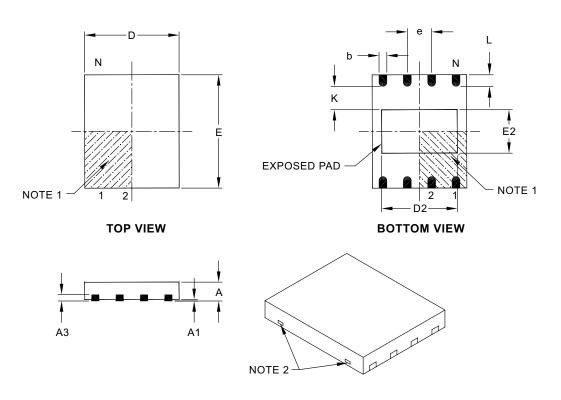
JEDEC equivalent: TO-220

Drawing No. C04-036

Revised 08-01-05

8-Lead Plastic Dual Flat, No Lead Package (MF) - 6x5 mm Body [DFN-S]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units				
Dimension I	Dimension Limits				
Number of Pins	N		8		
Pitch	е		1.27 BSC		
Overall Height	Α	0.80	0.85	1.00	
Standoff	A1	0.00	0.01	0.05	
Contact Thickness	А3	0.20 REF			
Overall Length	D	5.00 BSC			
Overall Width	E		6.00 BSC		
Exposed Pad Length	D2	3.90	4.00	4.10	
Exposed Pad Width	E2	2.20	2.30	2.40	
Contact Width	b	0.35	0.40	0.48	
Contact Length §	L	0.50	0.60	0.75	
Contact-to-Exposed Pad §	K	0.20	_	_	

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package may have one or more exposed tie bars at ends.
- 3. § Significant Characteristic
- 4. Package is saw singulated
- 5. Dimensioning and tolerancing per ASME Y14.5M $\,$

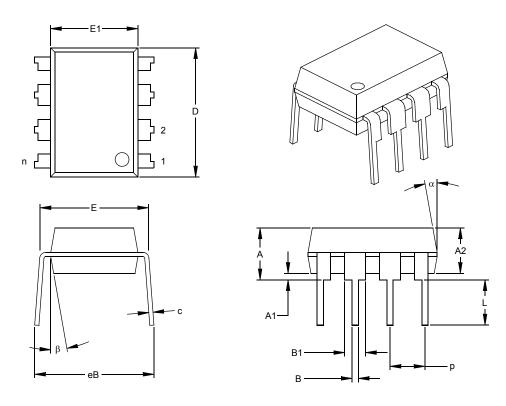
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-122, Sept. 8, 2006

8-Lead Plastic Dual In-line (PA) - 300 mil Body (PDIP)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	Units INCHES*				MILLIMETERS		
Dimensio	n Limits	MIN	NOM	MAX	MIN	NOM	MAX	
Number of Pins	n		8			8		
Pitch	р		.100			2.54		
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32	
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68	
Base to Seating Plane	A1	.015			0.38			
Shoulder to Shoulder Width	Е	.300	.313	.325	7.62	7.94	8.26	
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60	
Overall Length	D	.360	.373	.385	9.14	9.46	9.78	
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43	
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38	
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78	
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56	
Overall Row Spacing §	eВ	.310	.370	.430	7.87	9.40	10.92	
Mold Draft Angle Top	α	5	10	15	5	10	15	
Mold Draft Angle Bottom	β	5	10	15	5	10	15	

^{*} Controlling Parameter

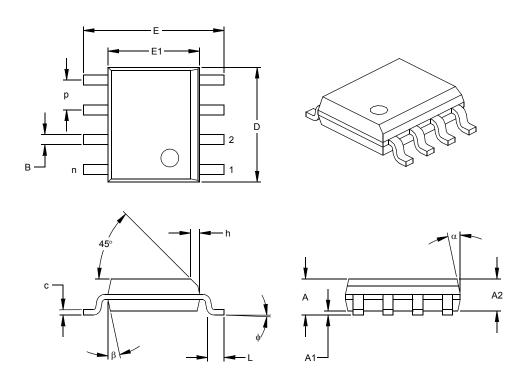
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-001

Drawing No. C04-018

[§] Significant Characteristic Notes:

8-Lead Plastic Small Outline (SN) - Narrow, 150 mil Body (SOIC)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units				MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8	-		8	
Pitch	р		.050			1.27	
Overall Height	Α	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	E	.228	.237	.244	5.79	6.02	6.20
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99
Overall Length	D	.189	.193	.197	4.80	4.90	5.00
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.019	.025	.030	0.48	0.62	0.76
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.013	.017	.020	0.33	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-012

Drawing No. C04-057

^{*} Controlling Parameter § Significant Characteristic

APPENDIX A: REVISION HISTORY

Revision A (December 2006)

• Original Release of this Document.

M	ICP	14	06	:/0	7
W			V		•

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. X	<u>xx </u>	Examples:	
Device Tempe Ran		a) MCP1406-E/MF: 6A High-Speed M Driver, Inverting 8LD DFN package.	
Device:	MCP1406: 6A High-Speed MOSFET Driver, Inverting MCP1406T: 6A High-Speed MOSFET Driver, Inverting	b) MCP1406-E/AT: 6A High-Speed M Driver, Inverting 5LD TO-220 packar	
	(Tape and Reel) MCP1407: 6A High-Speed MOSFET Driver, Non-Inverting	c) MCP1406-E/SN: 6A High-Speed M Driver, Inverting 8LD SOIC package	
	MCP1407T: 6A High-Speed MOSFET Driver, Non-Inverting (Tape and Reel)	d) MCP1406-E/P: 6A High-Speed M Driver, Inverting 8LD PDIP package	OSFET
Temperature Range:	E = -40°C to +125°C	e) MCP1406T-E/MF: Tape and Reel, 6A High-Speed M	
Package: *	AT = TO-220, 5-Lead MF = Dual, Flat, No-Lead (6x5 mm Body), 8-lead PA = Plastic DIP, (300 mil body), 8-lead SN = Plastic SOIC (150 mil Body), 8-Lead * All package offerings are Pb Free (Lead Free)	Driver, Inverting, 8LD DFN pkg. f) MCP1406T-E/SN: Tape and Reel, 6A High-Speed M Driver, Inverting, 8LD SOIC pkg.	10SFET
		a) MCP1407-E/MF: 6A High-Speed M Driver, Non-Invertin 8LD DFN package.	ıg
		b) MCP1407-E/AT: 6A High-Speed M Driver, Non-Invertin 5LD TO-220 packat	ıg
		c) MCP1407-E/SN: 6A High-Speed M Driver, Non-Invertin 8LD SOIC package	ıg
		d) MCP1407-E/P: 6A High-Speed M Driver, Non-Invertin 8LD PDIP package	ıg
		e) MCP1407T-E/MF: Tape and Reel, 6A High-Speed M Driver, Non-Invertin 8LD DFN pkg.	OSFET
		f) MCP1407T-E/SN: Tape and Reel, 6A High-Speed M Driver, Non-Invertin 8LD SOIC pkg.	

M	P 1	1	N	R	V).	7
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NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
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